

DSS-TN40

Environment Test Report

Report NO: 13I020023

Summary	<input checked="" type="checkbox"/> Pass <input type="checkbox"/> Fail Note : There is/are ____ defect(s) not list in the report, please check it in the DTS Website. <input type="checkbox"/> Pass with Deviation Comment:
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Issue date

2013-08-07

Approval

Tom Lin

Test Engineer

Jerry Chen

Test item list

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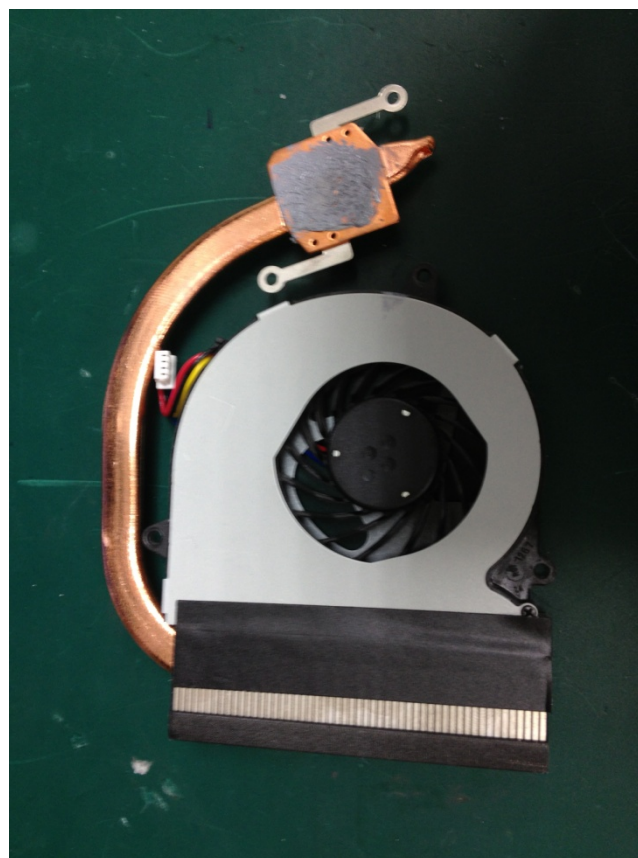
Testing Result

Num	Test item list	Result	Remark
1	Temperature rise test	Pass	
2	Temperature cycle operation test	Pass	
3	High temperature storage test	Pass	
4	Low temperature storage test	Pass	
5	Humidity test	Pass	
6	Cold start and hot start test	Pass	

Configuration of EUT

Num	Item	Spec
1.	Control Box:	DSS-TN40 A1.0
	1. Main Board	EMB-A70M
	2. BIOS Ver.	DSS-TN40 R1.0 (DS40AM10) (05/15/2013)
	3. CPU	AMD R-260H APU with Radeon HD Graphics / 2.1GHz
	4. Memory	DSL DDR3 1066 4GB*2 / ELPIDA J2108BDBG-DJ-F
	5. HDD	WD 2500BPVT SATA 2.5" HDD 250GB
	6. Test Software	Windows 7 / Run PassMark Burn In Test 7.0 Pro
2.	AC Adapter	FSP. FSP060-DBAE1 Output: 12V; 5.0A MAX

Fan



Temperature rise test

Test Date: 08-05-2013

Test Product: DSS-TN40

Test Site: AAEON QE Dept.

Test Standard: Reference EN 61131-2(94), UL508 (94)

Temperature Measurement:

40 Channel Thermal Recorder: (YOKOGAWA Inc.)
 Model: DA100-13-1D
 Date of Calibration: 10/08/12
 Serial Number: 12A323190

Test Condition:

Ambient temperature: 45°C
 Continuous running till thermal stability (within less than 1°C)

Test Software:

Windows 7 / Run PassMark Burn In Test 7.0 Pro

Terminal Recorder:

Measuring Thermal Couple Position :

DSS-TN40

Point	Temp. Stage(°C)	Spec	45	25	Note
AIS-E2-CV1					
01. U22 (TF)AMD APU.R-series.2.0GHz. 827P.RE460LSIE44HJE.R-460L		100	66.2	46.2	
02. U47 (TF) Hudson-M3 Fusion.AMD.A70M		105	60	40	
03. U46 (TF) Low-Voltage LDO Regulator.UPL.UP0104PSU8		100	62.3	42.3	
04. U61 (TF) 7.1+2 Channel Audio Codec. REALTEK.ALC892-CG		100.5	59.7	39.7	
05. L4 (TF)CYNTEC.PCMB104E-3R3MS		100	53.1	33.1	
06. L3 (TF) Panasonic.ETQP3W4R7WFN		125	53.4	33.4	
07. Memory chipset - 1		95	58.1	38.1	
08. Memory chipset - 2		95	56	36	
09. Q72 (TF)PWR.Dual N-Channel MOSFET.SMD.SO-8.IR.IRF8313PbF		150	55.6	35.6	
10. L10 (TF)COIL. Panasonic.ETQP4LR56WFC		100	62.7	42.7	
11. WD 2500BPVT SATA 2.5" HDD 250GB		60	49.2	29.2	
12. Control Box Inside Air Temperature – 1		NA	50.5	30.5	
13. Control Box Inside Air Temperature – 2		MA	43.6	23.6	
14. Control Box External Surface - 1		NA	50.4	30.4	
15. Chamber Air Temperature		NA	45	25	

Temperature rise test

Note(*):

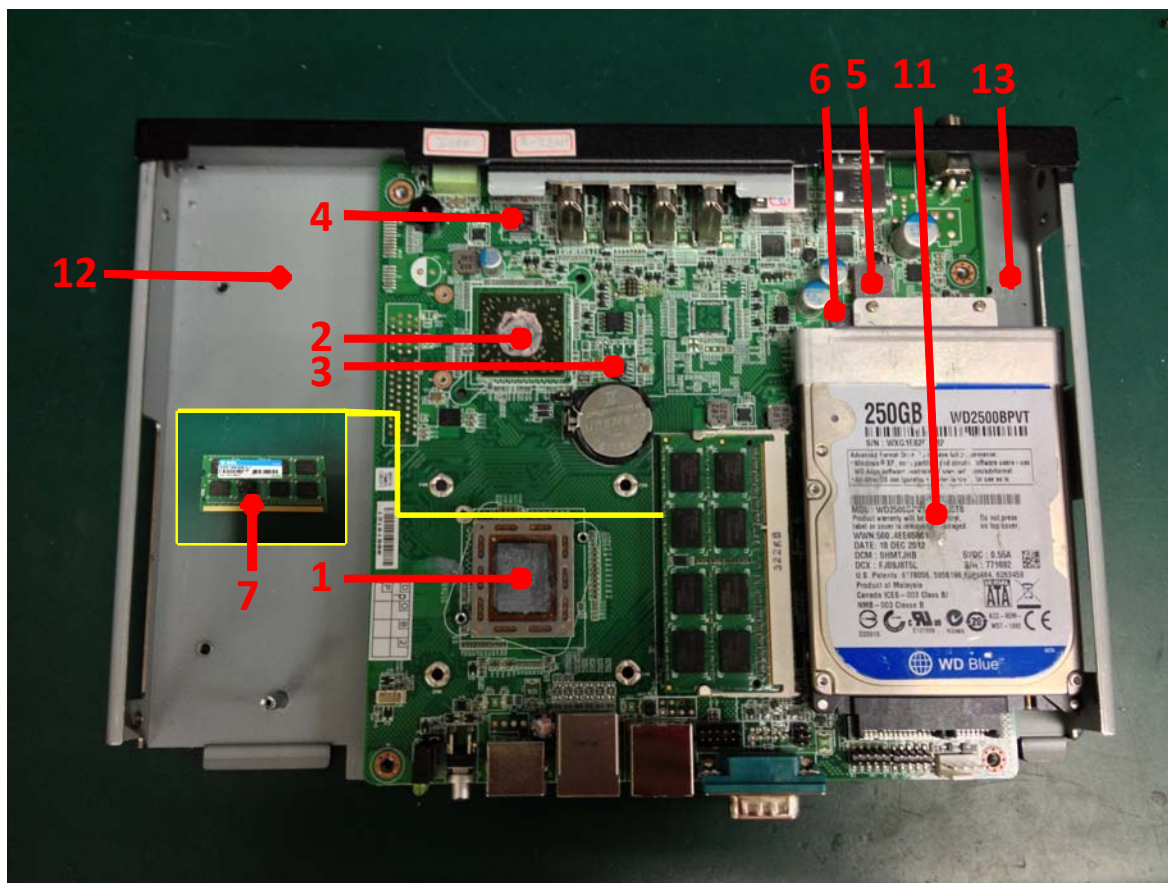
1. "Tc" indicates the component's case maximum temperature value specified in its datasheet.
2. "Tm" indicates the measured Tc value under working environmental temperature within product specification.
3. **Judgment Criteria:**
 - **Fail** : $T_m > T_c$; The measured value is over specification.
 - **Margin Pass** : $T_c > T_m > T_c - 5^{\circ}\text{C}$; The measured value is within specification with margin.
It is strongly recommended to add thermal dissipation design for better reliability.
 - **Pass** : $T_m < T_c - 5^{\circ}\text{C}$; The measured value is with safety margin.
4. **Defect NO.**

Sample Configuration & Quantity Under Test:

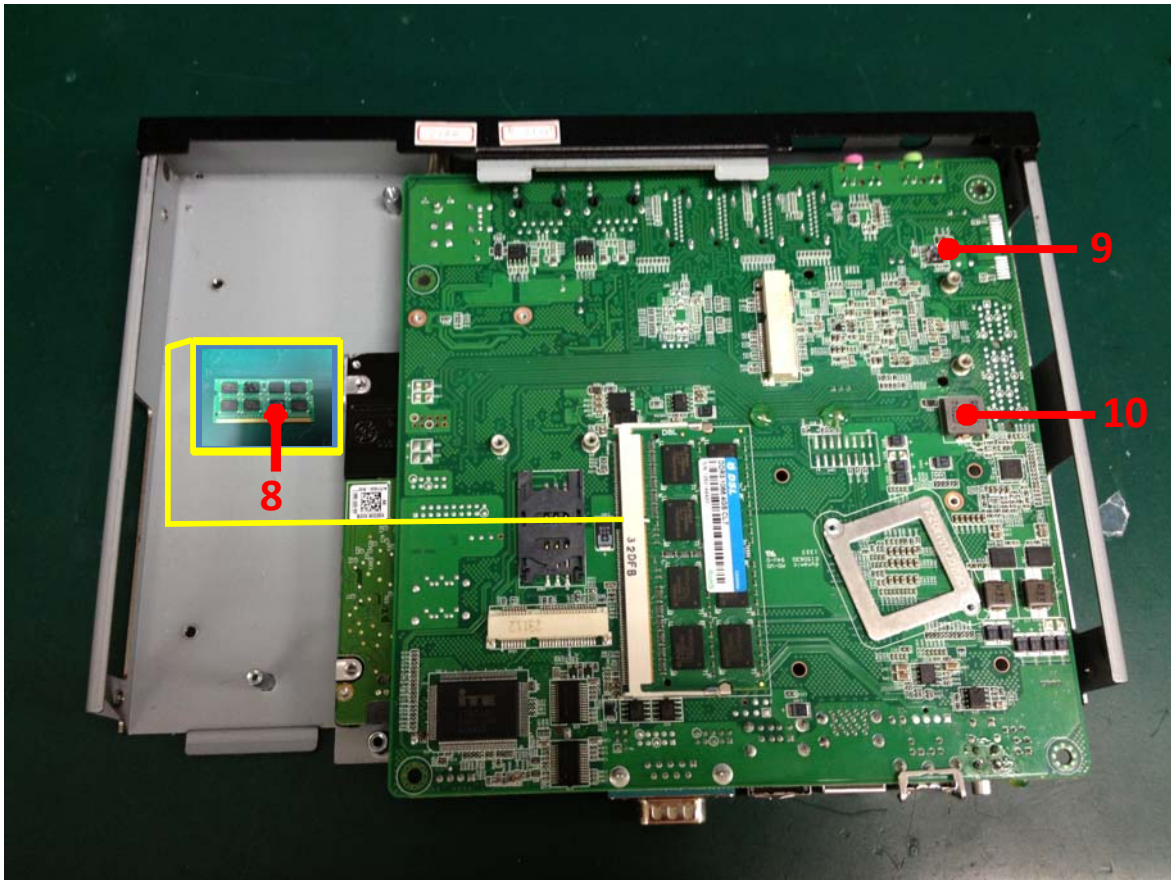
Quantity: 1 (DSS-TN40)

Test Result:

No issues were found during the temperature rise test.



Temperature rise test



Temperature cycle operation test

Test Date: 07-24 ~ 26-2013

Test Product: DSS-TN40

Test Site: AAEON QE Dept.

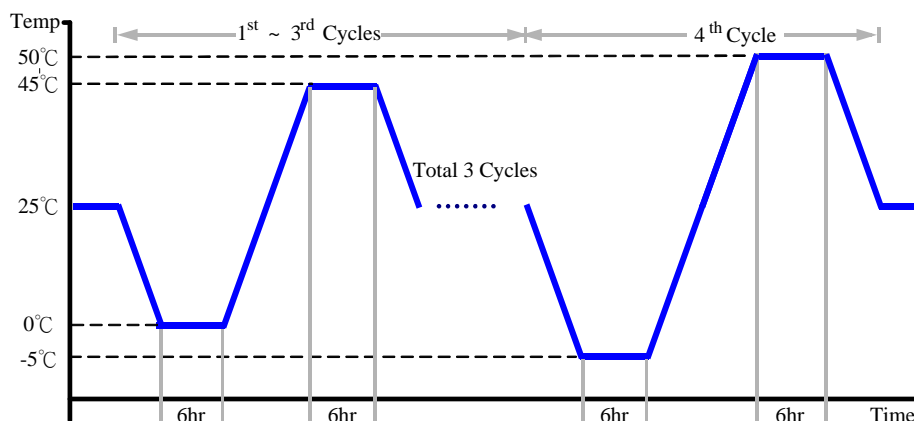
Test Standard: Refer to IEC68-2-14 Testing procedures
 Test N: Change of temperature Test

Test Equipment:

Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
 Model: THS-B6T-150+LN2
 Date of Calibration: 03/07/13
 Serial Number: 6487KT

Test Condition:

1. Test Low Temperature: 0°C (1~3 cycles)
 -5°C (4th cycle)
2. Test High Temperature: 45°C (1~3 cycles)
 50°C (4th cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 4 cycles
6. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (DSS-TN40)

Test Result:

No issues were found during the temperature operation cycle test.

High temperature storage test

Test Date: 07-26 ~ 29-2013

Test Product: DSS-TN40

Test Site: AAEON QE Dept.

Test Standard: Refer to IEC 68-2-2 Testing procedures
Test Bb: Dry Heat Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
Model: THS-B6T-150+LN2
Date of Calibration: 03/07/13
Serial Number: 6487KT

Testing Item:

1. Test Temperature: 60°C
2. Test Times: 48Hrs
3. Test Software: Windows 7 / Run PassMark Burn In Test 7.0 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (DSS-TN40)

Test Result:

No issues were found after the high temperature storage test.

Low temperature storage test

Test Date: 07-29~ 31-2013

Test Product: DSS-TN40

Test Site: AAEON QE Dept.

Test Standard: Refer to IEC 68-2-1 Testing procedures
Test Ab: Cold Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
Model: THS-B6T-150+LN2
Date of Calibration: 03/07/13
Serial Number: 6487KT

Testing Item:

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows 7 / Run PassMark Burn In Test 7.0 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (DSS-TN40)

Test Result:

No issues were found after the low temperature storage test.

Humidity test

Test Date: 07-31~ 08-02-2013

Test Product: DSS-TN40

Test Site: AAEON QE Dept.

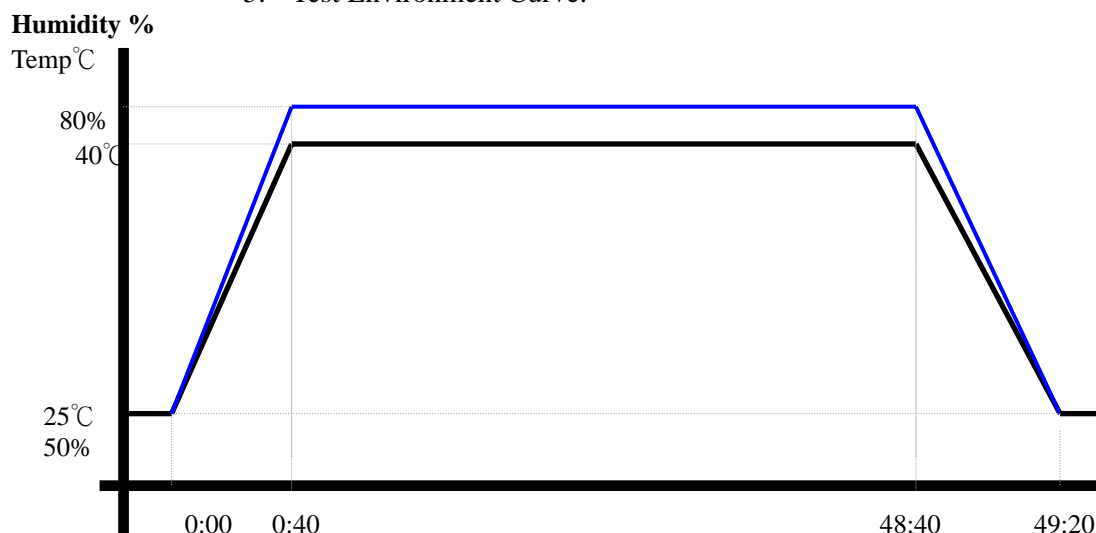
Test Standard: Refer to IEC 68-2-3 Testing procedures
 Test Ca: Damp heat, steady state (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
 Model: THS-B6T-150+LN2
 Date of Calibration: 03/07/13
 Serial Number: 6487KT

Testing Item:

1. Test Temperature: 40°C
2. Test Humidity: 80%RH
3. Test Times: 48Hrs
4. Test Software: Windows 7 / Run PassMark Burn In Test 7.0 Pro
5. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (DSS-TN40)

Test Result:

No issues were found after the humidity storage test.

Cold start and hot start test

Test Date: 08-02~05-2013

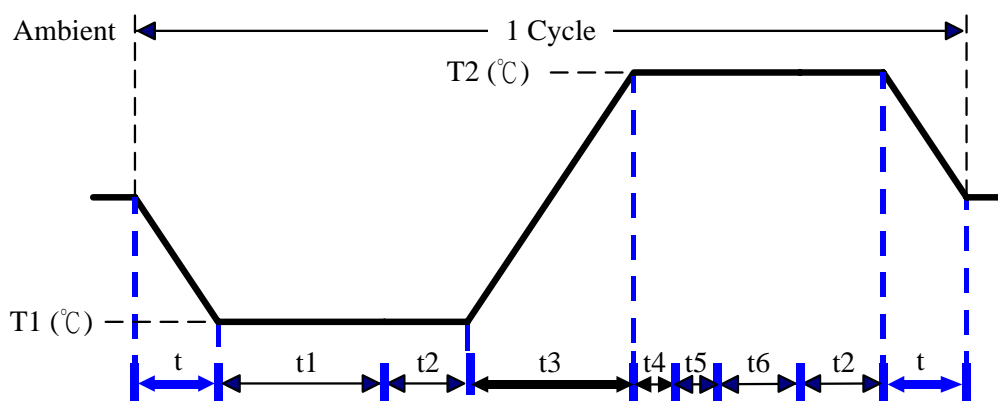
Test Product: DSS-TN40

Test Site: AAEON QE Dept.

Test Standard: Refer to IEC 68-2-14 Testing procedures
 Test N: Change of temperature Test

Test Equipment:
 Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
 Model: THS-B6T-150+LN2
 Date of Calibration: 03/07/13
 Serial Number: 6487KT

Test Condition:



Parameters	Description
T1	-5°C
T2	50°C
t1	4 hrs
t2, t6	2 hrs
t4, t5	1hrs
t, t3	2°C/min
n (Cycle)	1

t = temprature slope
 t, t1, t6: Power Off
 t2: Power on/off test 5 times (on 2 min / off 5min)
 t3, t4: Run PassMark BurnIn Test 7.0 Pro
 t5: Win 7 Software restart test 3 times
 Test Software: Windows 7

Test Result:

- a. No issues were found during the cold start test.
- b. No issues were found during the hot start test.